# MOSFET - Power, N-Channel, SO-8 30 V, 14.8 A

# **Features**

- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- This is a Pb-Free Device

# **Applications**

- Disk Drives
- DC-DC Converters
- Printers

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise stated)

-			Symbol		
Param	Parameter			Value	Unit
Drain-to-Source Voltage	in-to-Source Voltage		$V_{DSS}$	30	V
Gate-to-Source Voltage			$V_{GS}$	±20	V
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	12.2	Α
Current R <sub>θJA</sub> (Note 1)		T <sub>A</sub> = 70°C	]	9.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T <sub>A</sub> = 25°C	P <sub>D</sub>	1.55	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	9.1	Α
Current R <sub>θJA</sub> (Note 2)	Steady	T <sub>A</sub> = 70°C		7.3	1
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T <sub>A</sub> = 25°C	P <sub>D</sub>	0.86	W
Continuous Drain		T <sub>A</sub> = 25°C	I <sub>D</sub>	14.8	Α
Current $R_{\theta JA}$ , $t \le 10 s$ (Note 1)		T <sub>A</sub> = 70°C		11.8	
Power Dissipation $R_{\theta JA}$ , $t \le 10 \text{ s(Note 1)}$		T <sub>A</sub> = 25°C	P <sub>D</sub>	2.3	W
Pulsed Drain Current	T <sub>A</sub> = 25°0	C, t <sub>p</sub> = 10 μs	I <sub>DM</sub>	50	Α
Operating Junction and S	storage Ten	nperature	T <sub>J</sub> , T <sub>stg</sub>	–55 to 150	°C
Source Current (Body Did	ode)		I <sub>S</sub>	2.9	Α
$(T_J = 25^{\circ}C, V_{DD} = 30 \text{ V}, )$	se Drain-to-Source Avalanche Energy C, $V_{DD}$ = 30 V, $V_{GS}$ = 10 V, $V_{K}$ L = 1.0 mH, $V_{K}$ R <sub>G</sub> = 25 $V_{K}$				mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pur	poses	TL	260	°C

### THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	80.5	°C/W
$Junction-to-Ambient - t \le 10 s (Note 1)$	$R_{\theta JA}$	54.9	
Junction-to-Foot (Drain)	$R_{\theta JF}$	19.5	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	145	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

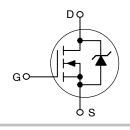


# ON Semiconductor®

# http://onsemi.com

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
30 V	6.1 mΩ @ 10 V	14.8 A
30 V	7.5 mΩ @ 4.5 V	14.0 A

### N-Channel





# MARKING DIAGRAM/ PIN ASSIGNMENT

Source Drain
Source Drain
Source Drain
Source Drain
Source Drain
Top View

4807N = Device Code A = Assembly Location Y = Year

WW = Work Week
■ Pb-Free Package

(Note: Microdot may be in either location)

# ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NTMS4807NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

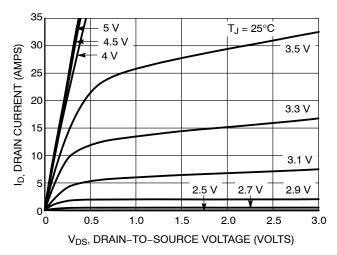
- Surfacemounted on FR4 board using 1 in sq pad size.
   Surfacemounted on FR4 board using the minimum recommended pad size.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>				29		mV/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V 0VV 04V	T <sub>J</sub> = 25°C			1.0	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 24 V	T <sub>J</sub> = 100°C			10	1
Gate-to-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> =				±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.5		3.0	V
Negative Threshold Temperature Coefficient	V <sub>GS(TH)</sub> /T <sub>J</sub>				6.0		mV/°C
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> =	14.8 A		5.1	6.1	mΩ
		V <sub>GS</sub> = 4.5 V, I <sub>D</sub> =	12 A		6.5	7.5	1
Forward Transconductance	9FS	V <sub>DS</sub> = 1.5 V, I <sub>D</sub> =	14.8 A		16		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE					
Input Capacitance	C <sub>iss</sub>				2900		pF
Output Capacitance	C <sub>oss</sub>	V <sub>GS</sub> = 0 V, f = 1.0 MHz	, V <sub>DS</sub> = 24 V		562		
Reverse Transfer Capacitance	C <sub>rss</sub>		-		307		
Total Gate Charge	Q <sub>G(TOT)</sub>				24		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>				3.4		1
Gate-to-Source Charge	Q <sub>GS</sub>	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}$	/, I <sub>D</sub> = 14.8 A		7.7		1
Gate-to-Drain Charge	$Q_{GD}$		-		10.4		
Total Gate Charge	Q <sub>G(TOT)</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 15 \	/, I <sub>D</sub> = 14.8 A		46		nC
SWITCHING CHARACTERISTICS (No	ote 4)				•	•	•
Turn-On Delay Time	t <sub>d(on)</sub>				14		ns
Rise Time	t <sub>r</sub>	V <sub>GS</sub> = 10 V, V <sub>DS</sub> =	- 15 V		6.5		
Turn-Off Delay Time	t <sub>d(off)</sub>	I <sub>D</sub> = 1.0 A, R <sub>G</sub> =			47		
Fall Time	t <sub>f</sub>		-		17		
DRAIN-SOURCE DIODE CHARACTE	RISTICS		L.			ı	
Forward Diode Voltage	$V_{SD}$		T <sub>J</sub> = 25°C		0.75	1.0	V
		$V_{GS} = 0 \text{ V}, I_{S} = 2.9 \text{ A}$	T <sub>J</sub> = 125°C		0.58		1
Reverse Recovery Time	t <sub>RR</sub>		'		30		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, } d_{IS}/d_t = 100 \text{ A/}\mu\text{s,}$ $I_S = 2.9 \text{ A}$			15		
Discharge Time	t <sub>b</sub>				15		
Reverse Recovery Charge	Q <sub>RR</sub>				23		nC
PACKAGE PARASITIC VALUES					•	<u> </u>	1
Source Inductance	L <sub>S</sub>	T <sub>A</sub> = 25°C			0.66		nH
Drain Inductance	L <sub>D</sub>	T <sub>A</sub> = 25°C			0.20		nH
Gate Inductance	L <sub>G</sub>	T <sub>A</sub> = 25°C			1.5		nH
Gate Resistance	R <sub>G</sub>	T <sub>A</sub> = 25°C			0.9	1.4	Ω

4.	Switching characteristics are independent of operating junction temperatures.

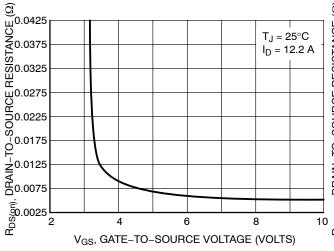
# **TYPICAL PERFORMANCE CURVES**



30 V<sub>DS</sub> ≥ 10 V 20 10 10 T<sub>J</sub> = 100°C T<sub>J</sub> = -55°C V<sub>GS</sub>, GATE-TO-SOURCE VOLTAGE (VOLTS)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



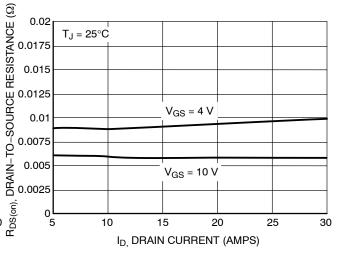
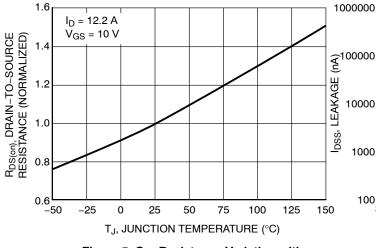


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



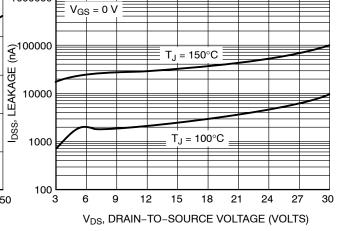


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

# **TYPICAL PERFORMANCE CURVES**

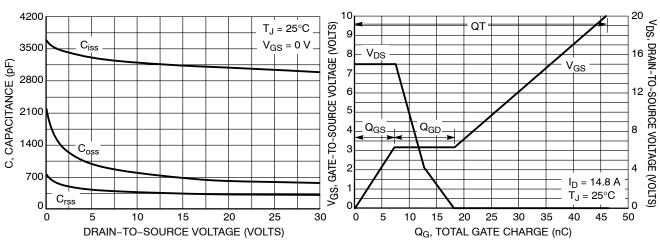


Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

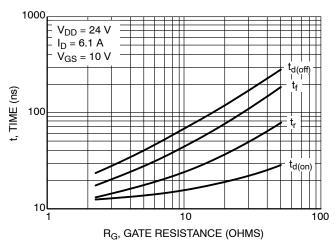


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

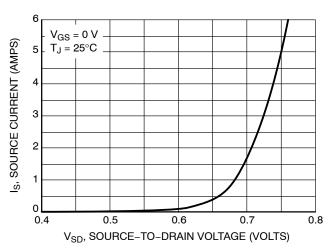


Figure 10. Diode Forward Voltage vs. Current

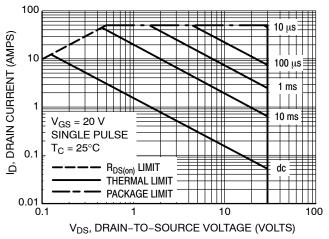


Figure 11. Maximum Rated Forward Biased Safe Operating Area

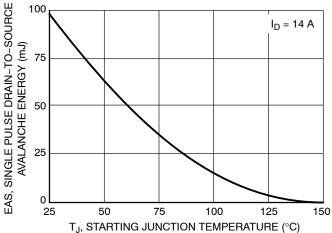
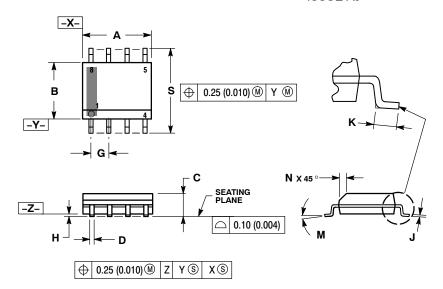


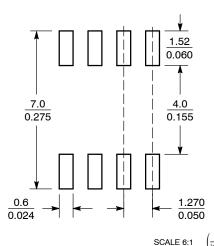
Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

# PACKAGE DIMENSIONS

# SOIC-8 CASE 751-07 **ISSUE AJ**



### **SOLDERING FOOTPRINT\***



Mounting Techniques Reference Manual, SOLDERRM/D.

### NOTES

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
- PER SIJE.

  DIMENSION D DOES NOT INCLUDE DAMBAR
  PROTRUSION. ALLOWABLE DAMBAR
  PROTRUSION SHALL BE 0.127 (0.005) TOTAL
  IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW
- STANDARD IS 751-07.

	MILLIMETERS		INCHES		
DIM	MIN MAX		MIN	MAX	
Α	4.80	4.80 5.00		0.197	
В	3.80	3.80 4.00		0.157	
C	1.35 1.75		0.053	0.069	
D	0.33 0.51		0.013	0.020	
G	1.27 BSC		0.050 BSC		
Н	0.10 0.25		0.004	0.010	
7	0.19	0.25	0.007	0.010	
K	0.40	1.27	0.016	0.050	
М	0 ° 8 °		0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5.80	5.80 6.20		0.244	

- STYLE 12: PIN 1. SOURCE
  - SOURCE
  - SOURCE 3. GATE 4
  - DRAIN
  - 6. 7. DRAIN
  - DRAIN DRAIN

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and

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